


<b>Search Notes</b>  	<b>Application/Control No.</b>  10620296	<b>Applicant(s)/Patent Under Reexamination</b>  TACHIBANA ET AL.
	<b>Examiner</b>  Mark W Bockelman	<b>Art Unit</b>  3766

SEARCHED			
Class	Subclass	Date	Examiner
604	22, 522, 500, 509	5-11-2008	/MB/
514	410, 145	5-11-2008	/MB/

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner